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Sheet 1 of 1

## U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
		US 6,360,055	03/19/2002	Toshihiko KANESHIGE et al.		
		US 2002/0145702	10/10/2002	Motoki KATO et al.		
		US 6,285,825	09/04/2001	Katsuhiko MIWA et al.		
		US 5,999,698	12/07/1999	Masatoshi NAKAI et al.		
		US 6,415,101	07/02/2002	Linden deCarmo et al.		
		US 2001/0053280	12/20/2001	Kazuhiko YAMAUCHI et al.		
		US 6,385,388	05/07/2002	Debbie LEWIS et al.		
		US 6,167,189	12/26/2000	Kazuhiko TAIRA et al.		
		US 6,219,488	04/17/2001	Yoshihiro MORI et al.		
		US 2003/0118327	06/26/2003	Soung Hyun UM et al.		
		US 6,377,747	04/23/2002	Kaoru MURASE et al.		

## FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
		CN 1317200	10/10/2001	China		Abstract	
		JP 2002-222581	08/09/2002	Japan		Abstract	
		KR 1999-22858	3/25/1999	Korea		Abstract	
		JP 10-40667	02/13/1998	Japan		Abstract	
		EP 1126454	08/22/2001	Europe			
		JP 2000-348442	12/15/2000	Japan		Abstract	
		EP 0836183	04/15/1998	Europe			
		EP 0836189	04/15/1998	Europe			

## OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

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Date Considered:

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